## Applicant(s)/Patent Under Application/Control No. Reexamination 10/750,883 ADACHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2826 Alexander O. Williams **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 414/160 US-2002/0187023 A1 12-2002 Araki, Itsuo Α 432/253 11-2002 Minami et al. US-2002/0172908 A1 В 211/41.18 Araki, Itsuo 09-2004 US-6,796,439 B2 С 438/758 Takagi, Mikio 03-2001 US-6,204,194 B1 D 438/680 07-2000 Inaba et al. US-6,093,644 Ε 211/41.18 05-2000 Uchiyama et al. US-6,065,615 F 432/253 07-1995 Yamabe et al. US-5,431,561 G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Yoshikawa et al. 12-1999 Japan 11-340155 Ν Sakagami et al. 08-2002 Japan 2002-43239 0 Yoshikawa et al. 04-2003 Japan 2003-100648 Ρ Kuroi et al. 07-2003 2003-197722 Japan Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.